Improving accuracy by sub-pixel smoothing in FDTD

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Abstract

Finite-difference time-domain (FDTD) methods suffer from reduced accuracy when modeling

discontinuous dielectric materials, due to the inhererent discretization ("pixellization"). We show

that accuracy can be significantly improved by using a sub-pixel smoothing of the dielectric func-

tion, but only if the smoothing scheme is properly designed. We develop such a scheme based on a

simple criterion taken from perturbation theory, and compare it to other published FDTD smooth-

ing methods. In addition to consistently achieving the smallest errors, our scheme is the only one

that attains quadratic convergence with resolution for arbitrarily sloped interfaces. Finally, we

discuss additional difficulties that arise for sharp dielectric corners.

PACS numbers:

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A popular numerical tool for photonics is the finite-difference time-domain (FDTD) method, which discretizes Maxwell's equations on a grid in space and time. [1] Here, we address difficulties in representing a discontinuous permittivity (ε) on such a grid, by proposing an anisotropic sub-pixel ε smoothing scheme adapted from spectral methods. [2, 3] We show that our method consistently achieves the smallest errors compared to previous smoothing schemes for FDTD. [4–6] Unlike methods that require modified field-update equations, [7] our method uses the standard center-difference expressions and is easy to implement (free code is available [8]).

When ε is represented by "pixels" on a grid (or "voxels" in 3d), two difficulties arise. First, a uniform grid makes it more difficult to model small features or to optimize device performance by continuous variation of geometric parameters. Second, the pixellized ε may be a poor representation of the dielectric function: diagonal interfaces produce "staircasing," and even interfaces aligned with the grid may be shifted by as much as a pixel. This increases the computational errors, and can even degrade the rate of convergence with the grid resolution—as was pointed out in Ref. 7, ε interfaces actually reduce the *order* of convergence from the nominal quadratic (error $\sim \Delta x^2$) of standard FDTD to only linear (error $\sim \Delta x$). We address both of these difficulties.

The first difficulty is addressed by any smoothing scheme: assign to each pixel some effective ε based on the materials and interfaces in/around the pixel. The effective ε can then vary continuously with geometry.[1] However, such a smoothing perturbs the problem being solved, changing the original discontinuous geometry to a smoothed geometry. Thus, smoothing may actually increase the error. To ensure that the error is reduced, and in fact to restore quadratic convergence, we propose a smoothing with zero first-order effect in Maxwell's equations.

Consider an interface between two isotropic ε materials crossing a pixel, with a unitnormal vector \mathbf{n} perpendicular to the interface (assumed locally flat for small pixels, deferring the question of corners until later). We assign to that pixel an inverse dielectric tensor (justified below):

$$\tilde{\varepsilon}^{-1} = \mathbf{P} \langle \varepsilon^{-1} \rangle + (\mathbf{1} - \mathbf{P}) \langle \varepsilon \rangle^{-1}, \tag{1}$$

where \mathbf{P} is the projection matrix $P_{ij} = n_i n_j$ onto the normal. The $\langle \cdots \rangle$ denotes an average over the voxel $s\Delta x \times s\Delta y \times s\Delta z$ (in 3d) surrounding the grid point in question, where s is a "smoothing diameter" in units of the grid spacing (s=1 except where noted). More precisely, FDTD employs a Yee grid in which different field components are computed at different locations,[1] and we find the averages (1) at each \mathbf{E} component's grid points. This $\tilde{\boldsymbol{\varepsilon}}$ is then used to compute $\mathbf{E} = \tilde{\boldsymbol{\varepsilon}}^{-1}\mathbf{D}$. For example, to compute E_x at its Yee-grid point $[i+0.5,j,k]=([i+0.5]\Delta x,j\Delta y,k\Delta z)$, only the first row of the $\tilde{\boldsymbol{\varepsilon}}^{-1}$ tensor for that point is needed. When $\tilde{\boldsymbol{\varepsilon}}^{-1}$ is not diagonal, we obtain D_y and D_z at the E_x point by simply averaging the D_y and D_z components from their four adjacent Yee points (similar to Ref. 9). Note that (1) has the nice property of being Hermitian for real scalar ε , and equals ε^{-1} for homogeneous pixels.

Equation (1) corresponds to discretizing a smoothed version of Maxwell's equations, where ε or its inverse has been anistropically convolved with a box-like smoothing kernel. It was proposed for use with a planewave method,[2, 3] based on effective-medium considerations, but we can also evaluate this and other schemes by a simple criterion from perturbation theory. In particular, even before we discretize the problem, smoothing ε causes the solution to be perturbed, and this perturbation can be analyzed via methods recently developed for high-contrast interfaces.[10, 11] To minimize this smoothing error, we simply require that the error be zero to first order in the smoothing diameter s as $s \to 0$. The remaining smoothing errors will be quadratic in the resolution (except in singular cases as discussed below). Near a flat interface, the effect of a perturbation $\Delta \varepsilon$ on computed quantities such as eigenfrequencies[10] or scattered powers[11] is proportional to $\Delta \varepsilon |\mathbf{E}_{\parallel}|^2 - \Delta(\varepsilon^{-1})|D_{\perp}|^2$, where \mathbf{E}_{\parallel} and D_{\perp} are the continuous surface-parallel and -perpendicular components of \mathbf{E} and \mathbf{D} , respectively. For the first-order change to be zero, $\Delta \varepsilon$ must be a tensor, such that $\Delta \varepsilon_{\parallel}$ and $\Delta \varepsilon_{\perp}^{-1}$ both integrate to zero (e.g. are equal and opposite on the two sides of the interface). A simple choice satisfying this condition is (1), which uses the mean $\langle \varepsilon \rangle$ for the

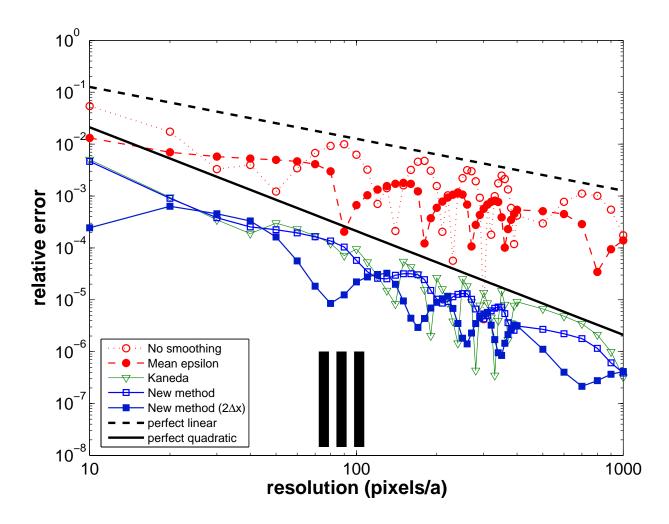


FIG. 1: TE eigenfrequency error vs. resolution for a bragg mirror of alternating air and $\varepsilon = 12$ (inset).

surface-parallel **E** components and the harmonic mean $\langle \varepsilon^{-1} \rangle^{-1}$ for the surface-perpendicular component.

Previous smoothing schemes do not satisfy this criterion, and are therefore expected to have only linear convergence in general, and may even have worse errors than unsmoothed FDTD. In particular, we compare to three other smoothings. The simplest is to use the scalar mean $\langle \varepsilon \rangle$ for all components,[5] which is incorrect for the surface-normal fields. Kaneda[4] proposed an anistropic smoothing that leads to diagonal $\tilde{\varepsilon}^{-1}$ tensors. We also consider the

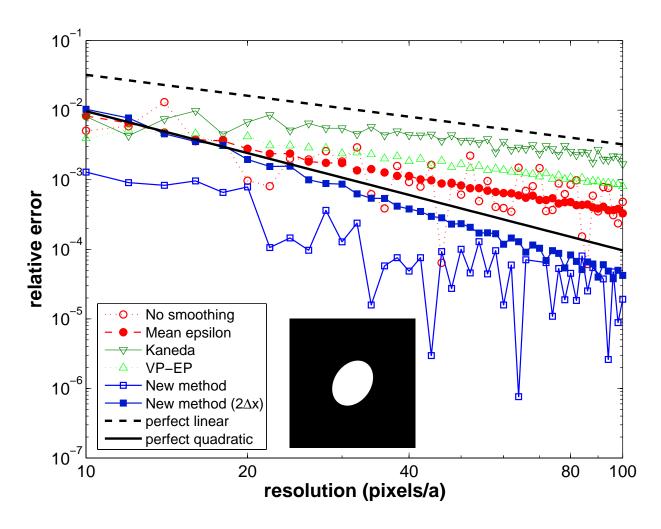


FIG. 2: TE eigenfrequency error vs. resolution for a square lattice of elliptical air holes in $\varepsilon = 12$ (inset).

"VP-EP" scheme,[6] which is exactly the diagonal part of (1) for s=1. Both Kaneda and VP-EP are equivalent to (1) for flat interfaces oriented along the grid (xyz) directions, but they do not satisfy the perturbation criterion for diagonal interfaces. Yet another method[9] was found to be numerically unstable for our test cases, which prevented us from evaluating it; however, it is equivalent to (1) only for flat x/y/z interfaces. Other schemes, not considered here, were developed for perfect conductors[1, 12] or for non-Yee lattices in 2d.[13] To evaluate the discretization error, we compute an eigenfrequency ω of a periodic (square

or cubic, period a) lattice of dielectric shapes with 12:1 ε contrast, a photonic crystal.[14] In particular, we compute the smallest ω for an arbitrarily chosen Bloch wavevector \mathbf{k} (not aligned with the grid), so that the wavelength is comparable to the feature sizes. We perform an FDTD simulation with Bloch-periodic boundaries and a Gaussian pulse source, analyzing the response with a filter-diagonalization method[15] to obtain the eigenfrequency ω . This is compared to the "exact" ω_0 from a planewave calculation[3] at a very high resolution, plotting the relative error $|\omega - \omega_0|/\omega_0$ versus FDTD resolution. ω is a good proxy for other common computations, because both the change in the frequency and the scattered power for a small $\Delta \varepsilon$ go as $\Delta \varepsilon |\mathbf{E}|^2$ to lowest order.[11]

To start with, we look at a 1d case in Fig. 1 where Kaneda, VP-EP, and Nadobny are equivalent to our method: a distributed bragg reflector (DBR) along the x direction, with a \mathbf{k} vector in the xy plane so that the eigenfield \mathbf{E} has components both parallel and perpendicular to the interfaces. We find that both the no-smoothing and simple mean- ε cases both have only linear convergence, whereas the new method (and Kaneda and Nadobny) have quadratic convergence.

Since Kaneda, VP-EP, and our method are equivalent for grid-parallel interfaces (and we obtain quadratic convergence for all these methods), we focus instead on a more complicated case: a square lattice of elliptical air holes shown in the inset of Fig. 2, for the TE polarization (\mathbf{E} in the 2d plane). Our new method (hollow squares) has the smallest errors by large margin, while the Kaneda and VP-EP methods are actually worse than no smoothing. As mentioned above, all methods except ours converge linearly, whereas we expect our method to be asymptotically quadratic. As a trick to make the quadratic convergence of our method more apparent, we double the smoothing diameter to s=2 (filled squares), at the expense of increasing the absolute error.

The TM polarization (\mathbf{E} out of the plane) is shown in Fig. 4 and is less interesting: all the smoothing methods are equivalent to the simple mean ε , all decrease the error compared to no smoothing, and *all* methods (including no smoothing) exhibit quadratic convergence. Since \mathbf{E} is everywhere continuous, TM is the "easy" case for numerical computation (and

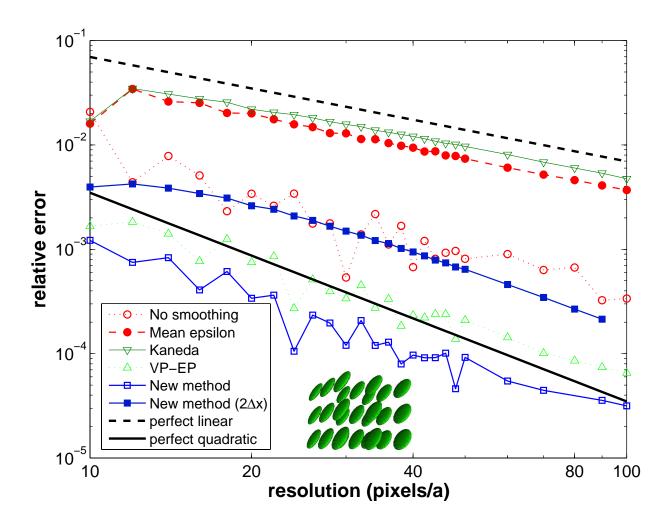


FIG. 3: Eigenfrequency error vs. resolution for a cubic lattice of $\varepsilon = 12$ ellipsoids in air (inset). perturbative methods[10, 11]).

In three dimensions, we used a cubic lattice of $\varepsilon = 12$ ellipsoids, with an arbitrary orientation, in air. The results in Fig. 3 again show that the new method has the smallest error, and is again quadratic. Notice that the ordering of the other methods has changed, and in general we observe them to yield erratic accuracy.

Finally, we consider a qualitatively different case, in which *none* of the methods satisfy our zero-perturbation criterion: the presence of a sharp corner leads to a new field singularity. Figure 5 shows the error for a square lattice of tilted air squares in $\varepsilon = 12$ (inset). Because

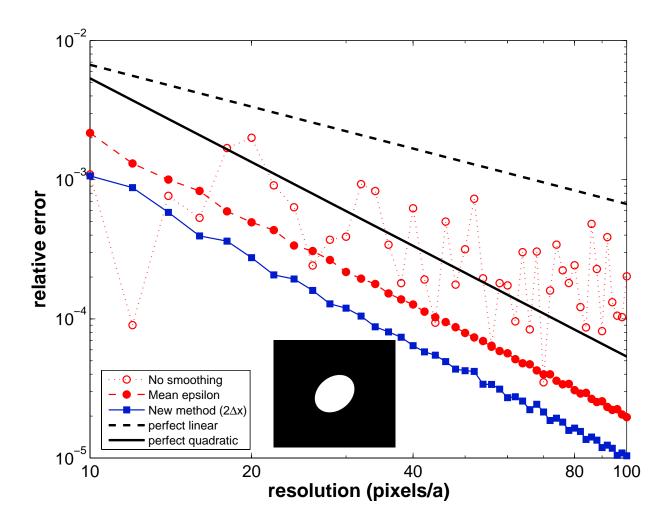


FIG. 4: TM eigenfrequency error vs. resolution for a square lattice of elliptical air holes in $\varepsilon = 12$ (inset).

our new method at least handles the flat edges properly, it still has lower error than other smoothing schemes, although suboptimal handling of the corner limits the differences. Fits of this data indicate that our method seems to be converging as $\Delta x^{1.4}$, and in fact this can be predicted analytically. Quite generally, any corner leads to a singularity where \mathbf{E} diverges as r^{p-1} for a radius r from the corner, with p given by a transcendental equation in the corner angle and ε 's (here, $p \approx 0.702$).[16] This leads to a perturbation in the frequency $\sim \int_{\Delta} |\mathbf{E}|^2 r dr \sim \Delta r^{2p} \approx \Delta r^{1.404}$, where Δr is the size of the perturbation (the pixel). Other

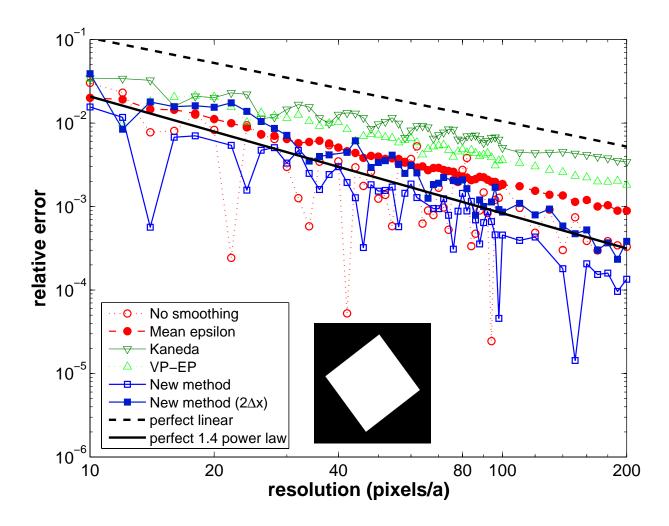


FIG. 5: Degraded accuracy due to field singularities at sharp corners: TE eigenfrequency error vs. resolution for square lattice of tilted-square air holes in $\varepsilon = 12$ (inset).

smoothing schemes, in contrast, are limited by the linear error from the flat interfaces.

In future work, we hope to extend our method to properly handle corners (where previous work has been limited to right-angle corners[17, 18]), by using the analytical knowledge of the singularity to design a corner smoothing. Anisotropic ε may be handled similar to Ref. 3.

This work was supported in part by the Materials Research Science and Engineering Center program of the National Science Foundation under award DMR-9400334, and by the

Office of Naval Research under award N00014-05-1-0700.

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